
Tan Dean D. Nguyen

3629

SEARCHED			
Class	Subclass	Date	Examiner
705	14	9/2005 12/2005	SW
	15		
	26		
	27		
709	217		
707	10		
	100		
358	613		
	1.15		
396	57		
	279		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
US	12/05	don
1) Patent	↓	↓
2) PGRub		
NPL		
diag, Ftext 1		
Ftext 2		
FOREign		
of		
JPO		
Reviewing Parent →		